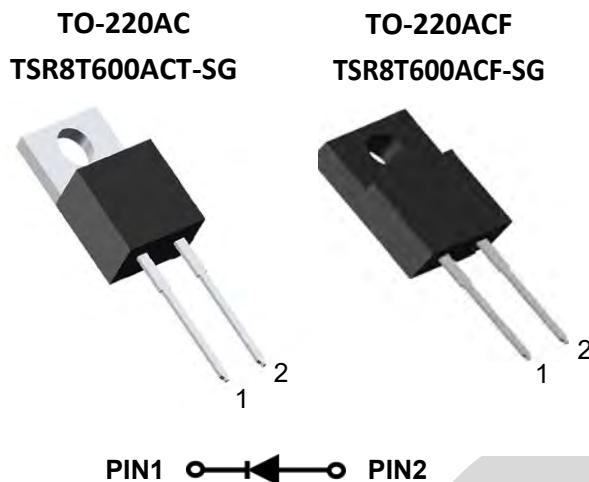


600V Schottky Diode



Features

- Insulated device with internal ceramic
- Low t_{RR} , Very low switching losses
- High dI/dt capable (1000A/ μ s)
- High voltage rectifier

Applications

- Epoxy: UL 94V-O rate flame retardant
- Lead: lead solderable per MIL-STD-202, method 208 guaranteed
- Power Factor Correction (PFC) Boost Diode
- DC-AC Inverters
- Motor drive circuits

Maximum ratings and electrical characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit		Unit
Maximum repetitive peak reverse voltage	V _{RRM}	600		V
Maximum average forward rectified current	I _{F(AV)}	8		A
Reverse Recovery Time. IF=0.5A,IR=1A,IRR=0.25A	T _{rr}	22		ns
Peak forward surge current 8.3 ms single half sine-wave superimposed on rated load per diode	I _{FSM}	80		A
Operating junction and storage temperature range	T _J , T _{STG}	-55 ~ +150		°C
Typical thermal resistance per leg	TO-220AC	R _{θJC}	2	
	TO-220ACF		4	
Instantaneous forward voltage per diode	VF(1)	TYP.	MAX.	
	IF=2A	T _J =25°C	1.62	-
	IF=2A	T _J =125°C	1.55	-
	IF=8A	T _J =25°C	1.95	2.20
	IF=8A	T _J =125°C	1.87	1.98
	IR(2)	1	50	uA
Instantaneous reverse current per diode at rated reverse voltage		30	300	uA

Notes:

(1) Pulse test: 300 μ s pulse width, 1 % duty cycle

(2) Pulse test: Pulse width \leq 40 ms

RATINGS AND CHARACTERISTICS CURVES ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Figure 1. Typical I_F vs V_F

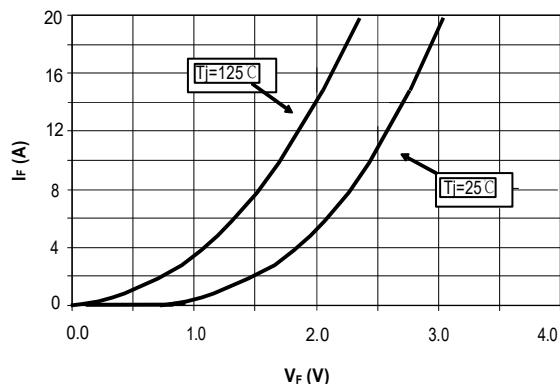


Figure 2. Typical Q_{RR} vs I_F at $T_j = 125^\circ\text{C}$

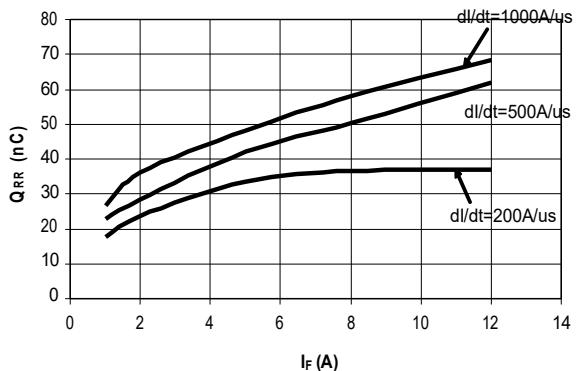


Figure 3. Typical t_{RR} vs I_F at $T_j = 125^\circ\text{C}$

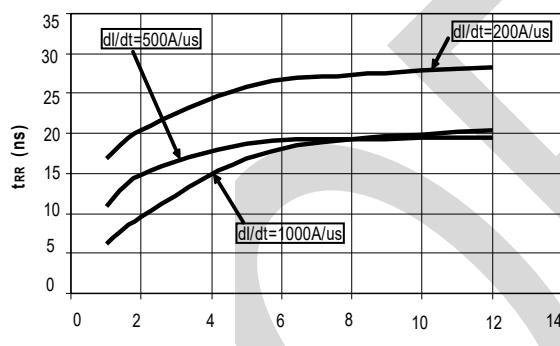


Figure 4. Current Derating, Case

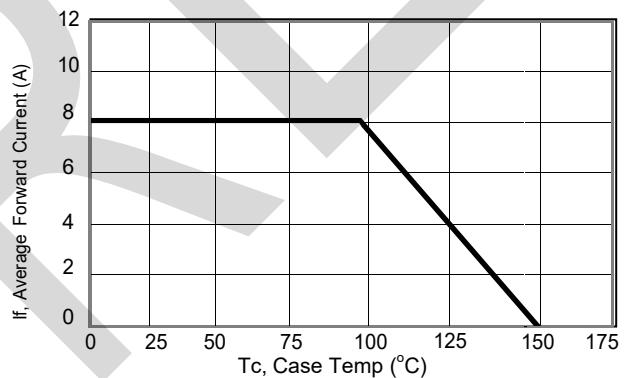
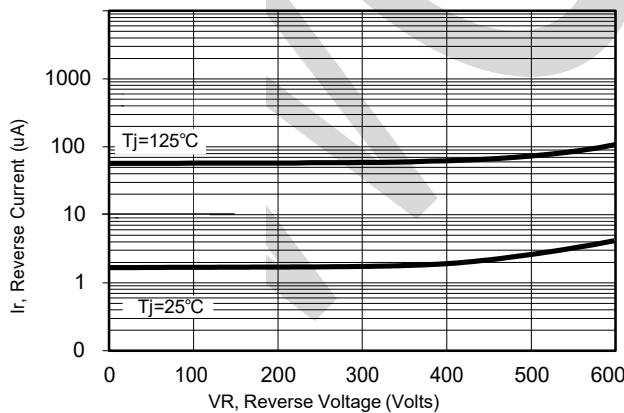


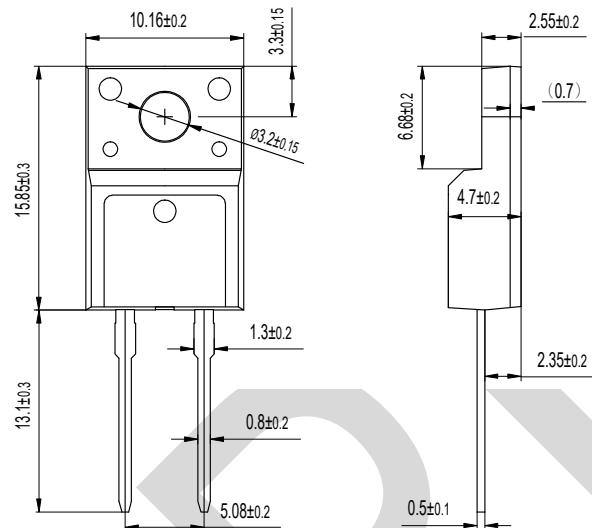
Figure 5. Typical Reverse Current



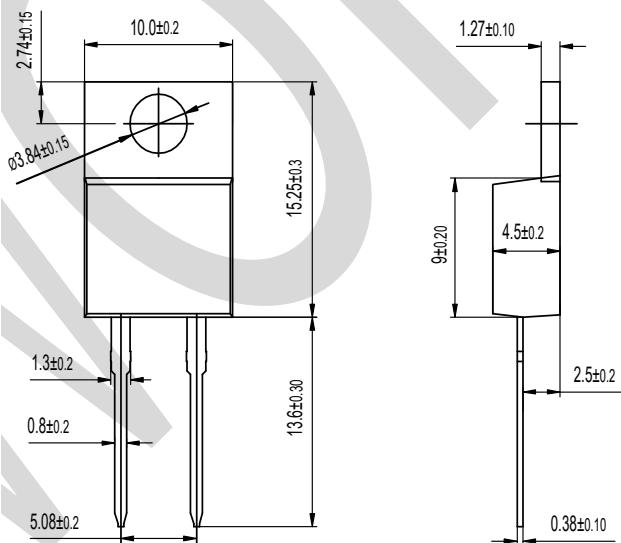
PACKAGE OUTLINE DIMENSIONS

Note:unit In(mm)

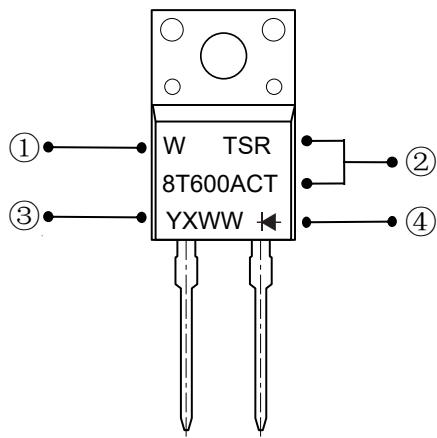
TO-220ACF Dimensions in millimeters



TO-220AC Dimensions in millimeters



Marking Information



① W : Company's trademark

② Product model : TSR8T600ACT-SG or TSR8T600ACF-SG

③ PDC information:

Y X WW

WW:Week code(01 to 53)

X:Internal identification code

Y:Year code(ex:0=2020)

④ ← Single wafer

ORV